

**FEATURES:**

- Enhanced N channel FET with no inherent diode to Vcc
- $5\Omega$  bidirectional switches connect inputs to outputs
- Zero propagation delay, zero ground bounce
- TTL-compatible input and output levels
- Undershoot clamp diodes on all switch and control inputs
- Available in SSOP and TSSOP packages

**APPLICATIONS:**

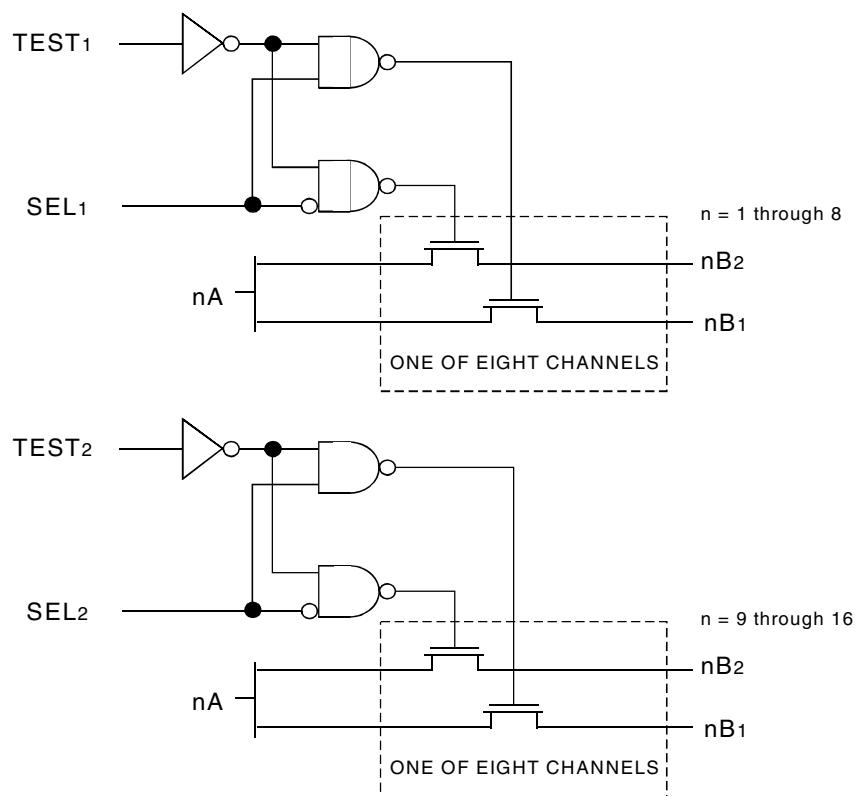
- Video, audio, graphics switching, muxing
- Hot-swapping, hot-docking
- Voltage translation (5V to 3.3V)
- Bus funneling

**DESCRIPTION:**

The QS316233 is a 32-bit to 16-bit high-speed CMOS, TTL-compatible switch which can multiplex or demultiplex data. It can be used for memory interleaving where two memory banks need to be addressed simultaneously. It can also be used as two 16-bit to 8-bit multiplexers or as one 32-bit to 16-bit multiplexer. SEL<sub>n</sub> inputs control the data flow. TEST<sub>n</sub> inputs control either one or two ports connection.

Mux/Demux devices provide an order of magnitude faster speed than equivalent logic devices.

The QS316233 is characterized for operation at -40°C to +85°C.

**FUNCTIONAL BLOCK DIAGRAM**


## PIN CONFIGURATION

1A	1	56	1B1
2B1	2	55	1B2
2B2	3	54	2A
3A	4	53	3B1
4B1	5	52	3B2
4B2	6	51	4A
5A	7	50	5B1
6B1	8	49	5B2
6B2	9	48	6A
7A	10	47	7B1
8B1	11	46	7B2
8B2	12	45	8A
GND	13	44	GND
Vcc	14	43	Vcc
9A	15	42	9B1
10B1	16	41	9B2
10B2	17	40	10A
11A	18	39	11B1
12B1	19	38	11B2
12B2	20	37	12A
13A	21	36	13B1
14B1	22	35	13B2
14B2	23	34	14A
15A	24	33	15B1
16B1	25	32	15B2
16B2	26	31	16A
TEST1	27	30	SEL1
TEST2	28	29	SEL2

SSOP/ TSSOP  
TOP VIEW

## ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>

Symbol	Description		Max	Unit
VTERM <sup>(2)</sup>	Supply Voltage to Ground		-0.5 to +7	V
VTERM <sup>(3)</sup>	DC Switch Voltage Vs		-0.5 to +7	V
VTERM <sup>(3)</sup>	DC Input Voltage Vin		-0.5 to +7	V
VAC	AC Input Voltage (pulse width ≤20ns)		-3	V
IOUT	DC Output Current		120	mA
P <sub>MAX</sub>	Maximum Power		0.93	W
	Dissipation (TA = 85°C)		0.77	TSSOP
TSTG	Storage Temperature		-65 to +150	°C

### NOTES:

1. Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.
2. Vcc terminals.
3. All terminals except Vcc .

## CAPACITANCE (TA = +25°C, f = 1MHz, VIN = 0V, VOUT = 0V)

Pins		Typ.	Max. <sup>(1)</sup>	Unit
Control Inputs		5	5.5	pF
Quickswitch Channels (Switch OFF)	Mux	8.5	10	pF
	Demux	6	7	

### NOTE:

1. This parameter is guaranteed but not production tested.

## PIN DESCRIPTION

Pin Names	I/O	Description
xA	I/O	Bus A
xB1, xB2	I/O	Bus B
SEL1, SEL2	I	Data Select
TEST1, TEST2	I	Port Select

## FUNCTION TABLES<sup>(1)</sup>

n = 1 through 8

SEL1	TEST1	xA	Function
L	L	xB1	xA to xB1
H	L	xB2	xA to xB2
X	H	xB1, xB2	xA to xB1 and xB2

n = 9 through 16

SEL2	TEST2	xA	Function
L	L	xB1	xA to xB1
H	L	xB2	xA to xB2
X	H	xB1, xB2	xA to xB1 and xB2

### NOTE:

1. H = HIGH Voltage Level
- L = LOW Voltage Level
- X = Don't Care

## DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE

Following Conditions Apply Unless Otherwise Specified:

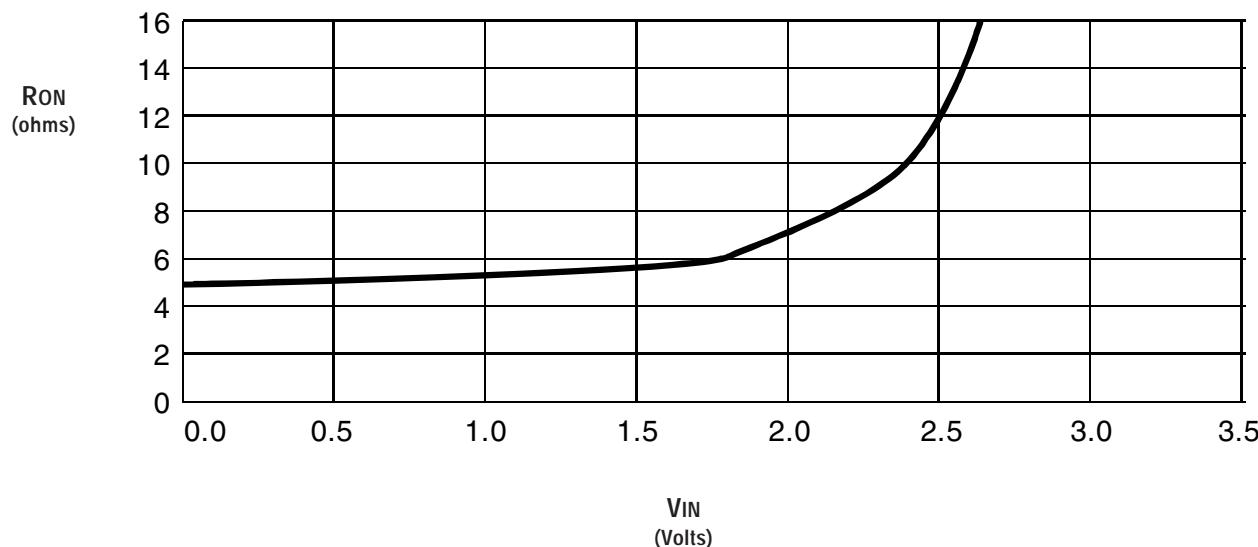
Industrial:  $T_A = -40^\circ\text{C}$  to  $+85^\circ\text{C}$ ,  $V_{CC} = 5\text{V} \pm 10\%$

Symbol	Parameter	Test Conditions	Min.	Typ. <sup>(1)</sup>	Max.	Unit
$V_{IH}$	Input HIGH Voltage	Guaranteed Logic HIGH for Control Inputs	2	—	—	V
$V_{IL}$	Input LOW Voltage	Guaranteed Logic LOW for Control Inputs	—	—	0.8	V
$I_{IN}$	Input Leakage Current (Control Inputs)	$0V \leq V_{IN} \leq V_{CC}$	—	—	$\pm 1$	$\mu\text{A}$
$I_{OZ}$	Off-State Current (Hi-Z)	$0V \leq V_{OUT} \leq V_{CC}$	—	—	$\pm 1$	$\mu\text{A}$
$R_{ON}$	Switch ON Resistance	$V_{CC} = \text{Min.}, V_{IN} = 0V, I_{ON} = 30\text{mA}$	—	5	7	$\Omega$
		$V_{CC} = \text{Min.}, V_{IN} = 2.4V, I_{ON} = 15\text{mA}$	—	10	12	
$V_P$	Pass Voltage <sup>(2)</sup>	$V_{IN} = V_{CC} = 5\text{V}, I_{OUT} = -5\mu\text{A}$	3.7	4	4.2	V

### NOTES:

1. Typical values are at  $V_{CC} = 5\text{V}$  and  $T_A = 25^\circ\text{C}$ .
2. Pass voltage is guaranteed but not production tested.

## TYPICAL ON RESISTANCE vs $V_{IN}$ AT $V_{CC} = 5\text{V}$



## POWER SUPPLY CHARACTERISTICS

Symbol	Parameter	Test Conditions <sup>(1)</sup>	Max.	Unit
I <sub>CCQ</sub>	Quiescent Power Supply Current	V <sub>CC</sub> = Max., V <sub>IN</sub> = GND or V <sub>CC</sub> , f = 0	3	µA
ΔI <sub>CC</sub>	Power Supply Current per Control Input HIGH <sup>(2)</sup>	V <sub>CC</sub> = Max., V <sub>IN</sub> = 3.4V, f = 0	3	mA
I <sub>CCD</sub>	Dynamic Power Supply Current per MHz <sup>(3)</sup>	V <sub>CC</sub> = Max., A and B Pins Open, Control Inputs Toggling @ 50% Duty Cycle	0.25	mA/MHz

NOTES:

1. For conditions shown as Min. or Max., use the appropriate values specified under DC Electrical Characteristics.
2. Per TTL-driven input (V<sub>IN</sub> = 3.4V). A and B pins do not contribute to ΔI<sub>CC</sub>.
3. This current applies to the control inputs only and represents the current required to switch internal capacitance at the specified frequency. The A and B inputs generate no significant AC or DC currents as they transition. This parameter is guaranteed but not production tested.

## SWITCHING CHARACTERISTICS OVER OPERATING RANGE

T<sub>A</sub> = -40°C to +85°C, V<sub>CC</sub> = 5V ± 10%

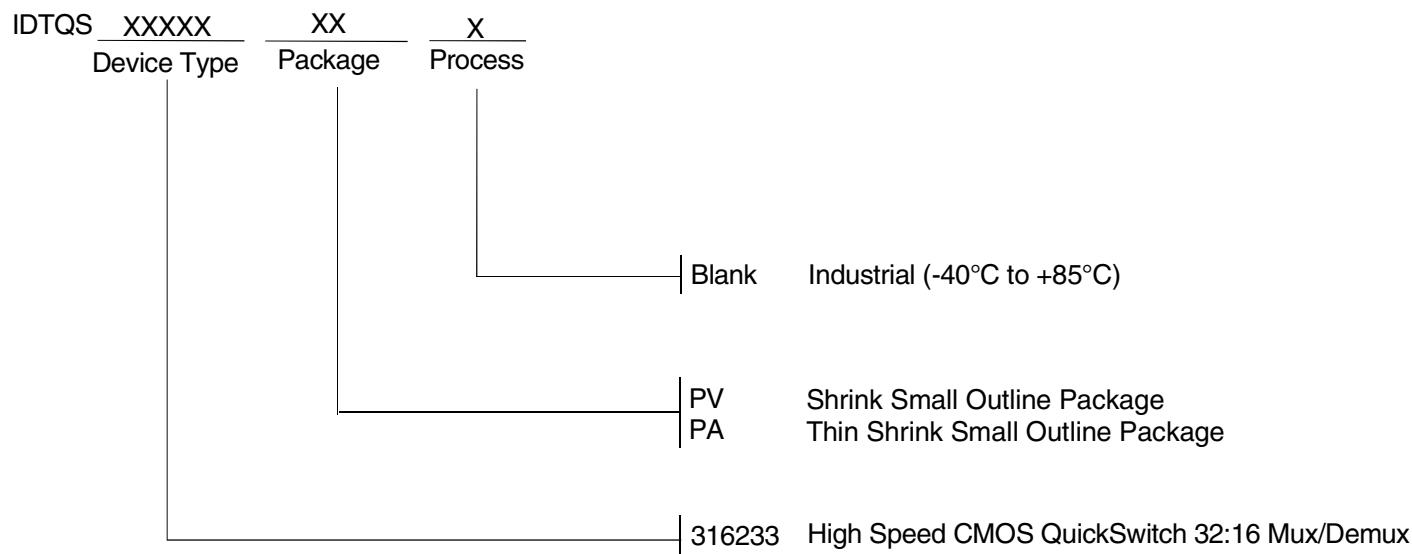
C<sub>LOAD</sub> = 50pF, R<sub>LOAD</sub> = 500Ω unless otherwise noted.

Symbol	Parameter	Min. <sup>(1)</sup>	Typ.	Max.	Unit
t <sub>PLH</sub> t <sub>PHL</sub>	Data Propagation Delay <sup>(2)</sup> xA to xBx, xBx to xA	—	—	0.25 <sup>(3)</sup>	ns
t <sub>BX</sub>	Switch Multiplex Delay SEL to xA	1.5	—	5.3	ns
t <sub>PZL</sub> t <sub>PZH</sub>	Switch Turn-On Delay SEL, TEST to xBx	1.5	—	5.2	ns
t <sub>PLZ</sub> t <sub>PHZ</sub>	Switch Turn-Off Delay <sup>(2)</sup> SEL, TEST to xBx	1.5	—	5.3	ns

NOTES:

1. Minimums are guaranteed but not production tested.
2. This parameter is guaranteed but not production tested.
3. The bus switch contributes no propagation delay other than the RC delay of the ON resistance of the switch and the load capacitance. The time constant for the switch alone is of the order of 0.25ns at C<sub>L</sub> = 50pF. Since this time constant is much smaller than the rise and fall times of typical driving signals, it adds very little propagation delay to the system. Propagation delay of the bus switch, when used in a system, is determined by the driving circuit on the driving side of the switch and its interaction with the load on the driven side.

## ORDERING INFORMATION



**CORPORATE HEADQUARTERS**  
6024 Silver Creek Valley Road  
San Jose, CA 95138

*for SALES:*  
800-345-7015 or 408-284-8200  
fax: 408-284-2775  
[www.idt.com](http://www.idt.com)

*for Tech Support:*  
[logichelp@idt.com](mailto:logichelp@idt.com)